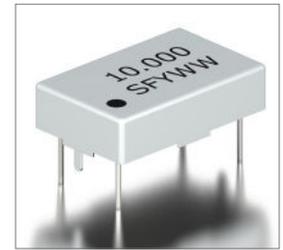
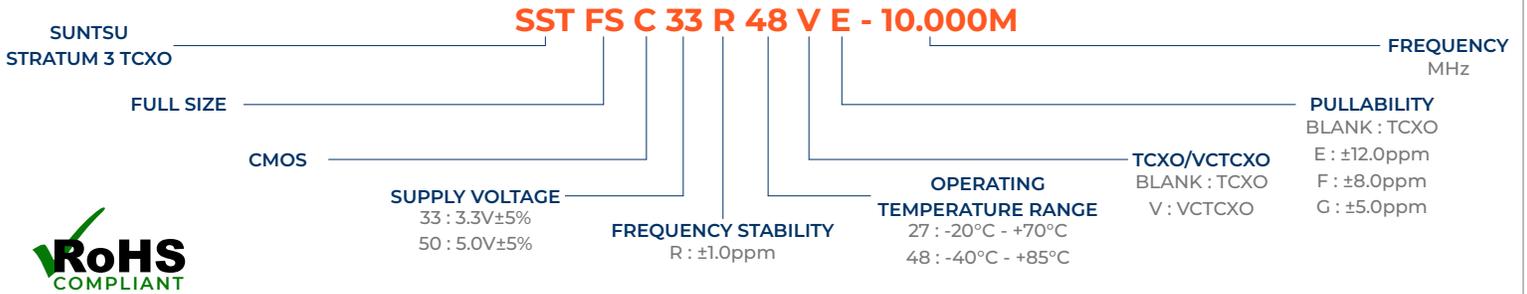


Features
<ul style="list-style-type: none"> Stratum 3 (Overall ± 4.6ppm) CMOS (VC)TCXO

Applications
<ul style="list-style-type: none"> Base Stations Stratum 3



Part Numbering Guide



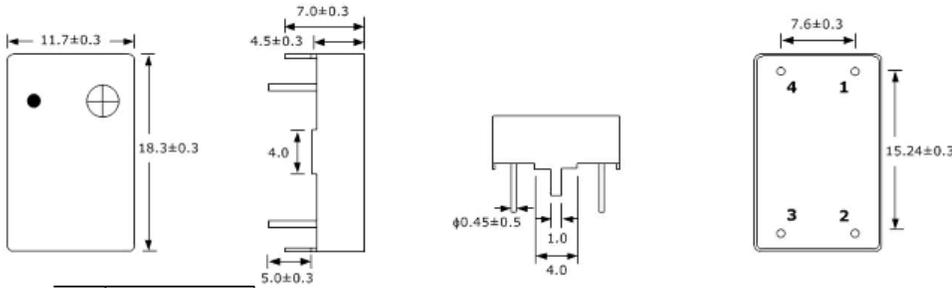
Cage Code: 4GUT4

To customize your parameters contact a Suntsu representative.

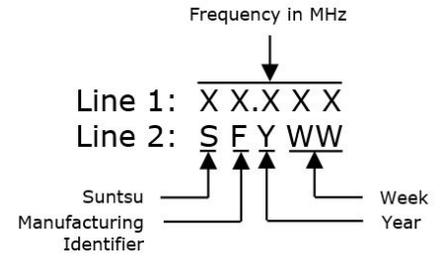
Electrical Parameters	Units	Minimum	Typical	Maximum	Remarks
Frequency Range	MHz	2		40	
Frequency Tolerance at +25°C	ppm	-0.3		+0.3	
Freq. Stability vs. Op Temp.	ppm	-1.0		+1.0	See part numbering guide for options.
Freq. Stability vs. Supply Voltage	ppm	-0.1		0.1	V _{DD} $\pm 5\%$ Change
Freq. Stability vs. Load	ppm	-0.1		0.1	$\pm 5\%$ Change
Freq. Stability vs. Aging/Year	ppm	-1.0		1.0	1 year, ± 2.6 ppm for 10years
Operating Temperature	°C	-40		+85	See part numbering guide for options.
Storage Temperature	°C	-55		+125	
Supply Voltage (V _{DD}) - 3.3V Option	V	3.135	3.3	3.465	
Supply Voltage (V _{DD}) - 5.0V Option	V	4.750	5.0	5.250	
Current (I _{DD})	mA			20	
Current (VC, VCTCXO) - 3.3V Option	V	0.3		3.0	
Current (VC, VCTCXO) - 5.0V Option	V	0.5		4.5	
Pullability (VCTCXO)	PPM	± 5.0		± 12.0	See part numbering guide for options.
Linearity (VCTCXO)	%			20	
Output Load (CMOS)	pF			15	
Output Level High (V _{OH})	V	0.9*V _{DD}			
Output Level Low (V _{OL})	V			0.1*V _{DD}	
Rise (T _R) And Fall (T _F) Time	ns			10	
Symmetry (Duty Cycle)	%	40	50	60	
Start-Up Time	ms			10	
Frequency Adjustment	ppm	3			
Phase Noise (Typical) 10Hz Offset	dBc/Hz		-80		
Phase Noise (Typical) 100Hz Offset	dBc/Hz		-120		
Phase Noise (Typical) 1KHz Offset	dBc/Hz		-135		
Phase Noise (Typical) 10KHz Offset	dBc/Hz		-140		
Phase Noise (Typical) 100KHz Offset	dBc/Hz		-145		

Outline Drawing & Part Marking

All dimensions are in millimeters (mm) unless otherwise noted. Drawings are not to scale.

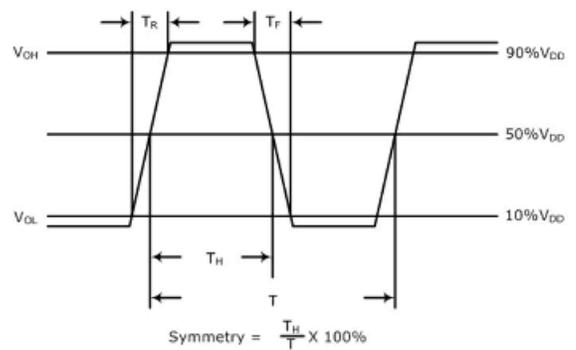
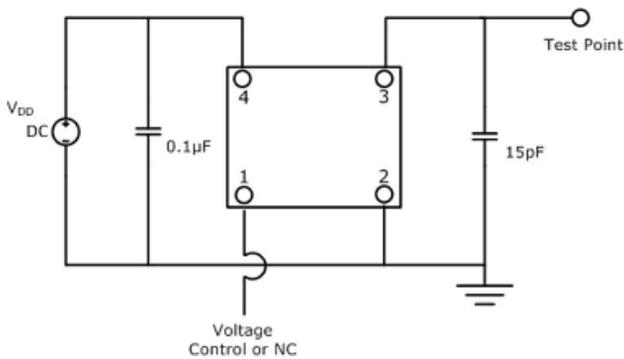


PIN	FUNCTION
1	V _C (VC1CXO) or V _C (TCXO)
2	GND
3	OUTPUT
4	V _{CC}

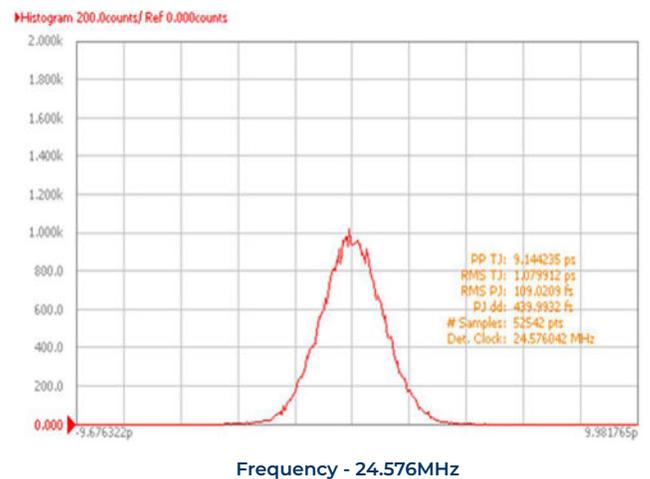
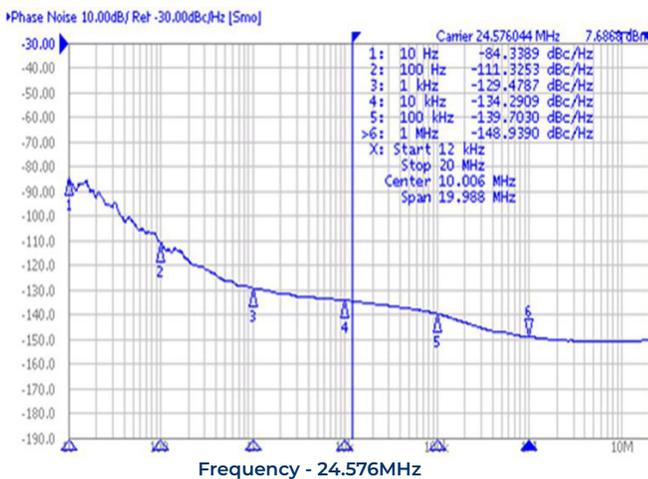


Test Circuit (CMOS)

Waveform (CMOS)



Typical Phase Noise And Jitter Performance (Measured By Agilent E5052A)



Environmental Specifications		Mechanical Specifications	
Temperature Cycling	MIL-STD-883, Method 1010, Condition B	Mechanical Shock	MIL-STD-202, Method 213, Condition B
Fine Leak Test	MIL-STD-883, Method 1014, Condition A	Vibration	MIL-STD-883, Method 2007, Condition A
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	Moisture Resistance	MIL-STD-883, Method 1004
Solderability	MIL-STD-883, Method 2003	Resistance to Solvents	MIL-STD-202, Method 215
Moisture Sensitivity	J-STD-020, MSL 1	Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K